

Attorney Docket No. MTI-31608

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

**Applicant** 

: Hock Chuan Tan et al.

Serial No.

10/068,159

Filing Date

February 5, 2002

For

Stacked Die in Die BGA Package

Examiner

TE TO D

Group Art Unit:

LE, Thao P.

Confirmation No.:

2818 8043

CERTIFICATION UNDER 37 CFR 1.8(a) and 1.10.

I hereby certify that, on the date shown below, this correspondence is being deposited with the United States Postal Service in an envelope addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313 450 are Express Mail Post Office to Addressee" Mailing Label No. EV405079799US.

Date:

August 18, goof

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

## **INFORMATION DISCLOSURE STATEMENT**

Sir:

Pursuant to 37 C.F.R. §§ 1.56 and 1.97, Applicant submits the information listed on the enclosed Form 1449/PTO for consideration in the above-identified application. No representation is made that a reference is "prior art" within the meaning of 35 U.S.C. §§ 102 and 103.

This Information Disclosure Statement is being filed in conjunction with a Request for Continued Examination (RCE). Accordingly, no fee is due for the consideration of these references.

Return of the enclosed Form 1449/PTO in the next communication to Applicant, showing the citations as initialed and considered, is respectfully requested.

Respectfully submitted,

Dated: /

<u>Navst 12</u>, 200

Kristine M. Strodthoff

Registration No. 34,259

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U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE
Washington, D.C. 20231

MTI-31608

Applicant

INFORMATION DISCLOSURE
STATEMENT BY APPLICANT

ATTY. DOCKET NO.

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## **U.S. PATENT DOCUMENTS**

February 5, 2002

Examiner Initial		Patent Number	Issue Date	Patentee	U.S. Class	Sub- Class
	<b>A</b> 1	5,804,004	09-08-1998	Brathwaite et al.	156	60
	A2	5,904,497	05-18-1999	Akram	438	106
	A3	6,084,308	07-04-00	Jackson et al.	257	777
	A4	5,910,686	06-08-99	Hamzehdoost et al.	257	778
	A5	4,571,611	02-18-86	Kashiwagi	257	707
	A6	6,340,842 B1	01-22-02	Nakamura	257	724

## FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

Examiner		Document	Publication	i	Int'l	Sub-	Translation
Initial		Number	Date	Country	Class	Class	(Yes/No)
	B1	11289023	10-19-99	JP	H01L	23/12	Abstract (US equivalent
							USP 6,340,842 – cited
							above)
	B2	10209204 A1	10-02-03	DE	H01L	21/58	Abstract
	B3	02109410	04-23-90	JP	H03H	9/25	Abstract
	B4	62185348	08-13-87	JP	H01L	23/32	Abstract
	B5	2003282818	10-03-03	JP	H01L	25/08	Abstract

**Examiner Initials** 

Date Considered

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.